

STH250N55F3-6

N-channel 55 V, 2.2 mΩ 180 A, H²PAK STripFET™ III Power MOSFET

Features

Order code	V _{DSS}	R _{DS(on)} max.	I _D	Pw
STH250N55F3-6	55 V	$2.6~\text{m}\Omega$	180 A ⁽¹⁾	300 W

- 1. Value limited by package
- Ultra low on-resistance
- 100% avalanche tested

Application

Switching applications

Description

This N-channel STripFET™ III Power MOSFET technology is among the latest improvements, which have been especially tailored to minimize on-state resistance providing superior switching performance.

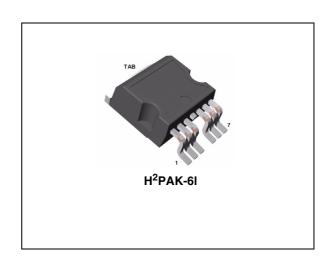


Figure 1. Internal schematic diagram

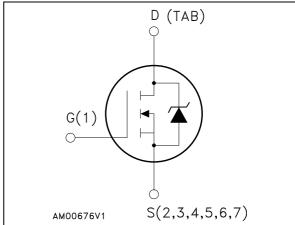


Table 1. Device summary

Order code	Marking	Package	Packaging
STH250N55F3-6	250N55F3	H ² PAK	Tape and reel

October 2010 Doc ID 18059 Rev 1 1/13

Contents STH250N55F3-6

Contents

1	Electrical ratings	. 3
2	Electrical characteristics	
3	Test circuits	. 8
4	Package mechanical data	. 9
5	Packaging mechanical data	11
6	Revision history	12

STH250N55F3-6 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} =0)	55	V
V _{GS}	Gate-source voltage	± 20	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	180	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C =100 °C	160	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	720	Α
P _{TOT}	Total dissipation at T _C = 25 °C	300	W
	Derating factor	2.0	W/°C
dv/dt (3)	Peak diode recovery voltage slope	11	V/ns
E _{AS} (4)	Single pulse avalanche energy	1000	mJ
T _j T _{stg}	Operating junction temperature storage temperature	- 55 to 175	°C

- 1. Current limited by package.
- 2. Pulse width limited by safe operating area.
- 3. I_{SD} \leq 120 A, di/dt \leq 900 A/µs, V_{DD} \leq $V_{(BR)DSS}$, T_{J} \leq T_{JMAX}
- 4. Starting Tj = 25 °C, I_D = 60 A, V_{DD} = 40 V (see Figure 16 and Figure 17)

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.5	°C/W
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-ambient max	35	°C/W

^{1.} When mounted on FR-4 board, on 1inch², 2oz Cu.

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	55			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max rating, V_{DS} = max rating,@125°C			10 100	μΑ μΑ
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20 V			±200	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 , I _D = 60 A		2.2	2.6	mΩ

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$	-	6800 1450 15	-	pF pF pF
$\begin{array}{c} t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \end{array}$	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 27.5 V, I_D = 60 A R_G = 4.7 ΩV_{GS} = 10 V (see Figure 13, Figure 18)	-	25 150 110 50	-	ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 44 \text{ V}, I_{D} = 120 \text{ A},$ $V_{GS} = 10 \text{ V},$ (see <i>Figure 14</i>)	-	100 30 26	-	nC nC nC

Table 6. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)		-		180 720	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =120 A, V _{GS} =0	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} =120 A, di/dt = 100 A/ μ s, V_{DD} = 35 V, Tj=150 °C (see <i>Figure 15</i>)	-	60 0.11 3.5		ns μC Α

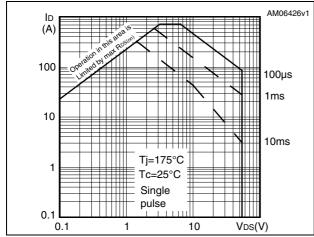
^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration = 300µs, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance



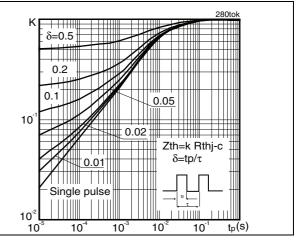
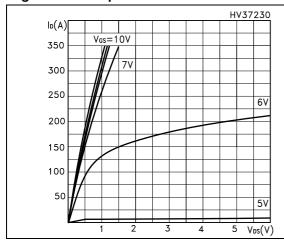


Figure 4. Output characteristics

Figure 5. Transfer characteristics



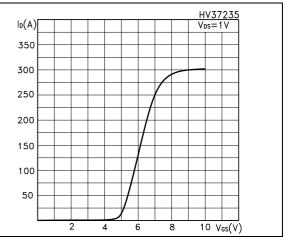
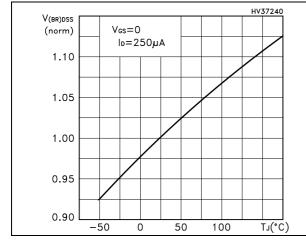
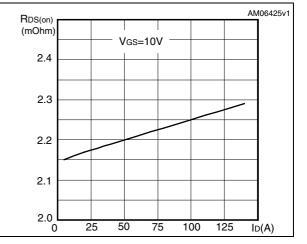


Figure 6. Normalized B_{VDSS} vs temperature

Figure 7. Static drain-source on resistance





Normalized on resistance vs

C(pF) Vgs(V) f=1MHz $V_{DD}=44V$ $V_{GS} = 0V$ ID=120A 8 16000 12000 Ciss 8000 2 4000 0 20 40 60 80 Q_g(nC) 10 20 30 0 V_{DS}(V) 40

Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. vs temperature

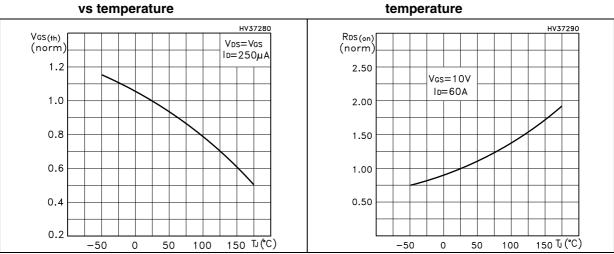
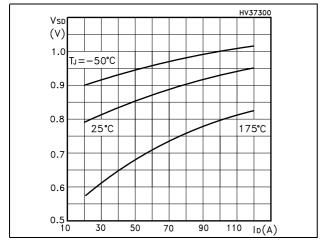


Figure 12. Source-drain diode forward characteristics



577

Test circuits STH250N55F3-6

3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

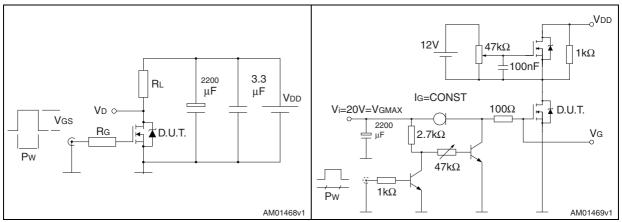


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

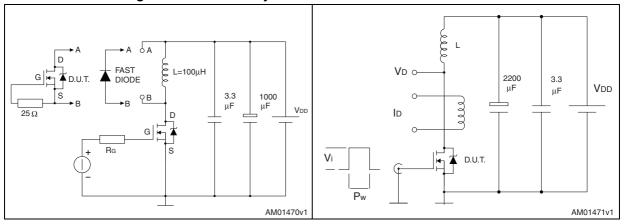
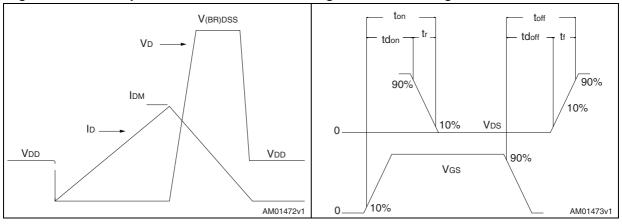


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 7. H²PAK-6 mechanical data

Dim		mm			
Dim.	Min.	Тур.	Max.		
Α	4.30		4.80		
A1	0.03		0.20		
С	1.17		1.37		
е	2.34		2.74		
e1	4.88		5.28		
e2	7.42		7.82		
E	0.45		0.60		
F	0.50		0.70		
Н	10.00		10.40		
H1	7.80	-	8.20		
L	14.75		15.25		
L1	1.27		1.40		
L2	4.35		4.95		
L3	7.45		7.85		
L4	1.5		1.75		
М	1.90		2.50		
R	0.20		0.60		
V	0°	1	8°		

577

Figure 19. H²PAK-6 drawing

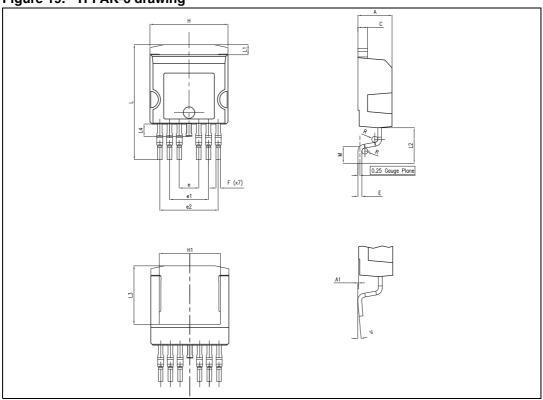
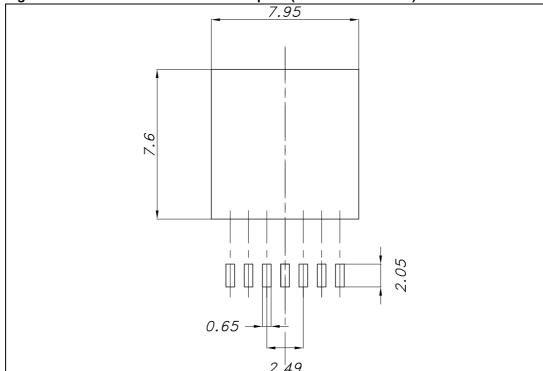


Figure 20. H²PAK-6 recommended footprint (dimensions in mm)



5 Packaging mechanical data

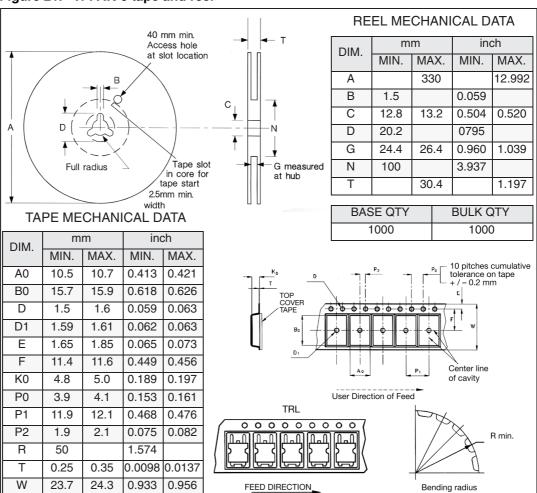


Figure 21. H²PAK-6 tape and reel

Revision history STH250N55F3-6

6 Revision history

Table 8. Revision history

Date	Revision	Changes
01-Oct-2010	1	First release

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13/13